

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/936,565	SAUK	
Examiner	Art Unit	
Christopher H. Yaen	1643	

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
530	300	7/18/2007	CHY	
514	2	7/18/2007	CHY	
Stic seq sea	irch of SEQ. and 13	7/18/2007	СНҮ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated searches	7/18/2007	СНҮ		
palm inventor search	7/18/2007	СНҮ		
reviewed stic seq search of SEQ. ID No: 9 and 13	7/18/2007	СНҮ		
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